Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/715,576	SASSER ET AL.
Examiner	Art Unit
James D. Stein	2874

SEARCHED				
Class	Subclass	Date	Examiner	
385	88,92,76	3/22/2006	JDS	
385	89	10/24/de	mc	
	<u> </u>			

ואו	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See attached EAST search history	3/22/2006	JDS
IEEE and INSPEC	3/21/2006	JDS
EAST: textatached	10/24/2	mc
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